



25V P-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

V _{(BR)DSS}	R _{DS(ON)}	Ι _D T _A = +25°C
251	10Ω @ V _{GS} = -4.5V	-0.17A
-25V	13Ω @ V _{GS} = -2.7V	-0.15A

Description

This new generation MOSFET has been designed to minimize the onstate resistance ($R_{DS(ON)}$) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- DC-DC Converters
- Power Management Functions

Features

- Low On-Resistance
- Low Gate Threshold Voltage
- Low Input Capacitance
- Fast Switching Speed
- Small Surfaced Mount Package
- ESD Protected Gate (>6kV Human Body Model)
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

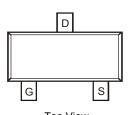
Mechanical Data

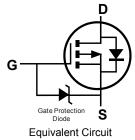
- Case: SOT23
- Case Material: Molded Plastic. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Solderable per MIL-STD-202, Method 208 (3)
- Lead Free Plating (Matte Tin Finish annealed over Alloy 42 leadframe).
- Terminal Connections: See Diagram
- Weight: 0.008 grams (approximate)





Top View





Top View Pin Configuration

Ordering Information (Note 4)

Part Number	Compliance	Case	Packaging
DMG302PU-7	Standard	SOT23	3,000/Tape & Reel
DMG302PU-13	Standard	SOT23	10,000/Tape & Reel

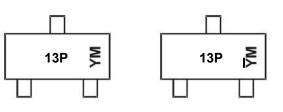
Notes: 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.

2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.

3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.

4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information



13P = Product Type Marking Code

 $\frac{YM}{YM} = \text{Date Code Marking for SAT (Shanghai Assembly/ Test site)} \\ \frac{YM}{YM} = \text{Date Code Marking for CAT (Chengdu Assembly/ Test site)} \\ Y \text{ or } Y = \text{Year (ex: } A = 2013) \\ M = \text{Month (ex: } 9 = \text{September)} \\ \end{cases}$

Date Code Key

Balo boab hoj												
Year	201	1	2012		2013	20	14	2015		2016	2	2017
Code	Y		Z		А	E	3	С		D		E
Month	Jan	Feb	Mar	Apr	Мау	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	Ν	D



Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Units		
Drain-Source Voltage		V _{DSS}	-25	V	
Gate-Source Voltage	V _{GSS}	-8	V		
Continuous Drain Current (Note 6) V_{GS} = -4.5V	Steady State	T _A = +25°C T _A = +70°C	Ι _D	-0.17 -0.14	A
Continuous Drain Current (Note 6) V _{GS} = -2.7V	ID	-0.15 -0.12	A		
Pulsed Drain Current T _P ≤ 300µs, Duty Cycle = 2%)	I _{DM}	-0.5	А		

Thermal Characteristics

Characteristic		Symbol	Value	Units	
Total Dowar Dissinction	(Note 5)	D	0.33	W	
Total Power Dissipation	(Note 6)	P _D	0.45	vv	
Thermal Desistance, Junction to Ambient	(Note 5)	P	376		
Thermal Resistance, Junction to Ambient	(Note 6)	R _{θJA}	275	°C/W	
Thermal Resistance, Junction to Case	(Note 6)	R _{ejc}	81		
Operating and Storage Temperature Range		T _{J,} T _{STG}	-55 to +150	°C	

Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

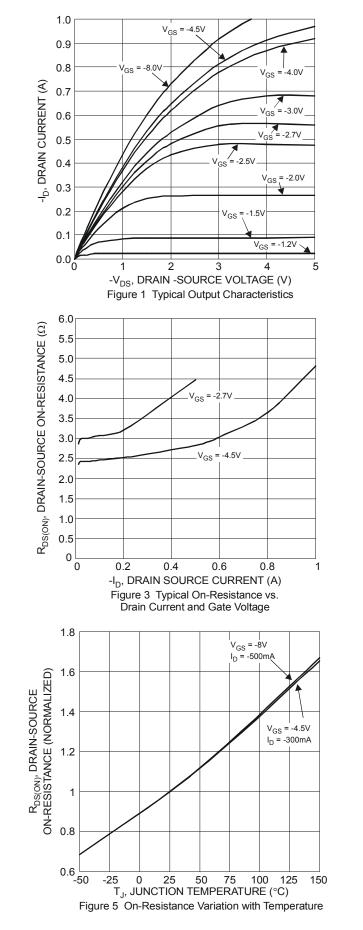
Characteristic	Symbol	Min	Tun	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 7)	Symbol	IVIIII	Тур	IVIdX	Unit	Test condition
				1		
Drain-Source Breakdown Voltage	BV _{DSS}	-25	—	—	V	$V_{GS} = 0V, I_D = -250\mu A$
Zero Gate Voltage Drain Current	I _{DSS}	_		-1	μA	V_{DS} = -20V, V_{GS} = 0V
Gate-Source Leakage	I _{GSS}	_	—	-100	nA	V _{GS} = -8V, V _{DS} = 0V
ON CHARACTERISTICS (Note 7)						
Gate Threshold Voltage	V _{GS(th)}	-0.65	-0.96	-1.5	V	$V_{DS} = V_{GS}, I_D = -250 \mu A$
Static Drain-Source On-Resistance		_	2.5	10	0	V _{GS} = -4.5V, I _D = -0.2A
Static Drain-Source On-Resistance	R _{DS(ON)}		3	13	Ω	V _{GS} = -2.7V, I _D = -0.05A
Forward Transfer Admittance	Y _{fs}		189	—	ms	$V_{DS} = -5V, I_D = -0.2A$
Diode Forward Voltage (Note 7)	V _{SD}	_	_	-1.5	V	V _{GS} = 0V, I _S = -0.2A
DYNAMIC CHARACTERISTICS (Note 8)						
Input Capacitance	C _{iss}	_	27.2	_		
Output Capacitance	Coss	_	6.1	_	pF	V _{DS} = -10V, V _{GS} = 0V f = 1.0MHz
Reverse Transfer Capacitance	C _{rss}	_	1.7	_		
Total Gate Charge	Qg		0.35	_		
Gate-Source Charge	Q _{gs}	_	0.08	_	nC	V _{DS} = -5V, I _D = -0.2A, V _{GS} = -4.5V,
Gate-Drain Charge	Q _{gd}	_	0.06	_		VGS4.5V,
Turn-On Delay Time	t _{d(on)}		4.5	_		
Rise Time	tr		2.3	_	1	V _{GS} = -4.5V, V _{DD} = -6V
Turn-Off Delay Time	t _{d(off)}		24.1	_	ns	$I_{\rm D}$ = -0.2A, $R_{\rm G}$ = 50 Ω
Fall Time	t _f		11.0	—]	

NEW PRODUCT

Notes:

Device mounted on FR-4 PC board, with minimum recommended pad layout, single sided.
Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper pad layout
Short duration pulse test used to minimize self-heating effect.
Guaranteed by design. Not subject to production testing.





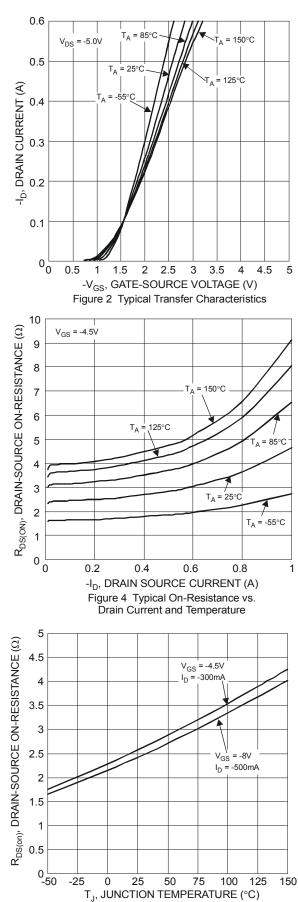
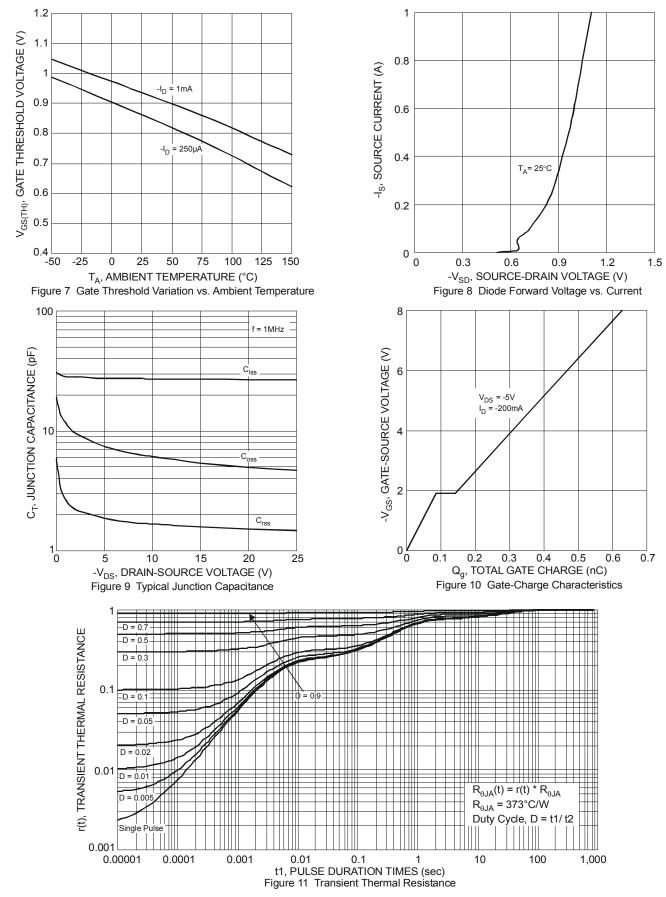


Figure 6 On-Resistance Variation with Temperature



NEW PRODUCT

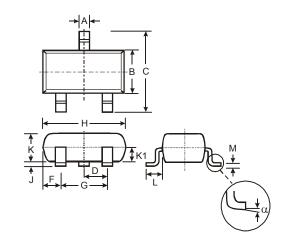
DMG302PU





Package Outline Dimensions

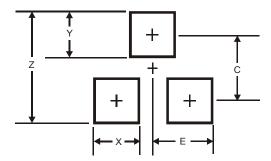
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.



SOT23							
Dim	Min	Max	Тур				
Α	0.37	0.51	0.40				
в	1.20	1.40	1.30				
C	2.30	2.50	2.40				
D	0.89	1.03	0.915				
F	0.45	0.60	0.535				
G	1.78	2.05	1.83				
Н	2.80	3.00	2.90				
J	0.013	0.10	0.05				
κ	0.903	1.10	1.00				
K1	-	-	0.400				
L	0.45	0.61	0.55				
М	0.085	0.18	0.11				
α	0°	8°	-				
All	All Dimensions in mm						

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
Z	2.9
Х	0.8
Y	0.9
С	2.0
E	1.35



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